Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/619,278	WU ET AL.
Examiner	Art Unit
Khanh Tran	2611

SEARCHED			
Class	Subclass	Date	Examiner
375	371-373 375-376	10/26/2006	кст
370	506,516		
327	156,162		
	163		

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Class	Subclass	Date	Examiner
	1		

SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
Search EAST	10/26/2006	кст
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